

Notice of References Cited	Application/Control No. 10/776,356	Applicant(s)/Patent Under Reexamination HSUEH, WEI-CHIEH	
	Examiner Leonid Shapiro	Art Unit 2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,859,193	02-2005	Yumoto, Akira	345/82
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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